## S29AL008D Known Good Die

## 8 Megabit (1 M x 8-Bit/512 K x 16-Bit) CMOS 3.0 Volt-only, Boot Sector Flash Memory



### Supplement

This product has been retired and is not recommended for designs. Please contact your Spansion representative for alternates. Availability of this document is retained for reference and historical purposes only.

### **Distinctive Characteristics**

- Single power supply operation
  - 2.7V to 3.6V for read, program, and erase operations
- Manufactured on 0.20µm process technology
- High performance
  - Access times as fast as 70 ns
- Ultra low power consumption (typical values at 5 MHz)
  - 200 nA Automatic Sleep mode current
  - 200 nA standby mode current
  - 7 mA read current
  - 15 mA program/erase current

#### ■ Flexible sector architecture

- One 16 Kbyte, two 8 Kbyte, one 32 Kbyte, and fifteen 64 Kbyte sectors (byte mode)
- One 8 Kword, two 4 Kword, one 16 Kword, and fifteen 32 Kword sectors (word mode)
- Supports full chip erase
- Sector Protection features:
- A hardware method of locking a sector to prevent any program or erase operations within that sector
- Sectors can be locked in-system or via programming equipment
- Temporary Sector Unprotect feature allows code changes in previously locked sectors

### ■ Unlock Bypass Program Command

- Reduces overall programming time when issuing multiple program command sequences
- Top or bottom boot block configurations available

### **■ Embedded Algorithms**

- Embedded Erase algorithm automatically preprograms and erases the entire chip or any combination of designated sectors
- Embedded Program algorithm automatically writes and verifies data at specified addresses
- Minimum one million write cycle guarantee per sector
- Compatibility with JEDEC standards
  - Pinout and software compatible with single-power supply Flash
  - Superior inadvertent write protection

#### ■ Data# Polling and toggle bits

 Provides a software method of detecting program or erase operation completion

#### ■ Ready/Busy# pin (RY/BY#)

Provides a hardware method of detecting program or erase cycle completion

#### ■ Erase Suspend/Erase Resume

 Suspends an erase operation to read data from, or program data to, a sector that is not being erased, then resumes the erase operation

### ■ Hardware reset pin (RESET#)

- Hardware method to reset the device to reading array data

### ■ 20-year data retention at 125°C

- Reliable operation for the life of the system
- Tested to data sheet specifications at temperature
- Quality and reliability levels equivalent to standard packaged components



### 1. General Description

The S29AL008D in Known Good Die (KGD) form is an 8 Mbit, 3.0 volt-only Flash memory. Spansion defines KGD as standard product in die form, tested for functionality and speed. Spansion KGD products have the same reliability and quality as Spansion products in packaged form.

### 1.1 S29AL008D Features

The S29AL008D is an 8 Mbit, 3.0 volt-only Flash memory organized as 1,048,576 bytes or 524,288 words. The word-wide data (x16) appears on DQ15–DQ0; the byte-wide (x8) data appears on DQ7–DQ0. To eliminate bus contention, the device has separate chip enable (CE#), write enable (WE#) and output enable (OE#) controls.

The device requires only a **single 3.0 volt power supply** for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations. No  $V_{PP}$  is required for program or erase operations. The device can also be programmed in standard EPROM programmers.

The device is entirely command set compatible with the **JEDEC single-power-supply Flash standard**. Commands are written to the command register using standard microprocessor write timings. Register contents serve as input to an internal state-machine that controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from other Flash or EPROM devices.

Device programming occurs by executing the program command sequence. This initiates the **Embedded Program** algorithm—an internal algorithm that automatically times the program pulse widths and verifies proper cell margin. The **Unlock Bypass** mode facilitates faster programming times by requiring only two write cycles to program data instead of four.

Device erasure occurs by executing the erase command sequence. This initiates the **Embedded Erase** algorithm—an internal algorithm that automatically preprograms the array (if it is not already programmed) before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies proper cell margin.

The host system can detect whether a program or erase operation is complete by observing the RY/BY# pin, or by reading the DQ7 (Data# Polling) and DQ6 (toggle) **status bits**. After a program or erase cycle is completed, the device is ready to read array data or accept another command.

The **sector erase architecture** allows memory sectors to be erased and reprogrammed without affecting the data contents of other sectors. The device is fully erased when shipped from the factory.

**Hardware data protection** measures include a low  $V_{CC}$  detector that automatically inhibits write operations during power transitions. The **hardware sector protection** feature disables both program and erase operations in any combination of the sectors of memory. This can be achieved in-system or via programming equipment.

The **Erase Suspend** feature enables the user to put erase on hold for any period of time to read data from, or program data to, any sector that is not selected for erasure. True background erase can thus be achieved.

The **hardware RESET# pin** terminates any operation in progress and resets the internal state machine to reading array data. The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the device, enabling the system microprocessor to read the boot-up firmware from the Flash memory.

The device offers two power-saving features. When addresses are stable for a specified amount of time, the device enters the **automatic sleep mode**. The system can also place the device into the **standby mode**. Power consumption is greatly reduced in both these modes.

Spansion's Flash technology combines years of Flash memory manufacturing experience to produce the highest levels of quality, reliability and cost effectiveness. The device electrically erases all bits within a sector simultaneously via Fowler-Nordheim tunneling. The data is programmed using hot electron injection.

## 1.2 Electrical Specifications

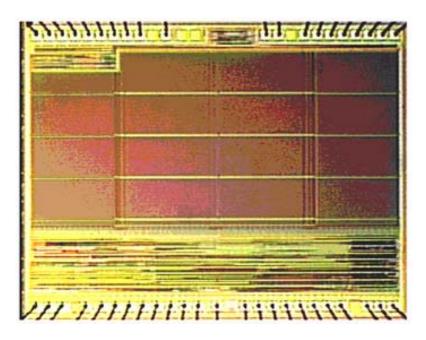
Refer to the S29AL008D data sheet, publication number S29AL008D\_00, for full electrical specifications on the S29AL008D in KGD form.

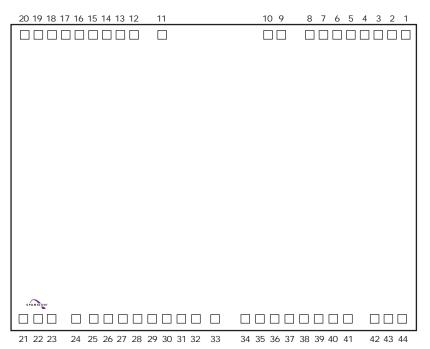


### 2. Product Selector Guide

| Family Part Number                           | S29AL0 | S29AL008D KGD |  |
|--|--------|---------------|--|
| Speed Option (V <sub>CC</sub> = 2.7V – 3.6V) | 70     | 90            |  |
| Max Access Time, t <sub>ACC</sub> (ns)       | 70     | 90            |  |
| Max CE# Access, t <sub>CE</sub> (ns)         | 70     | 90            |  |
| Max OE# Access, t <sub>OE</sub> (ns)         | 30     | 35            |  |

## 3. Die Photograph & Pad Locations





Note: Wirebond must be 100% within bond pad opening.



# 4. Pad Description

Table 4.1 Pads Relative to Die Center

| D- 111  | Pad Center (mils) |         |         | Pa     | Pad Center (millimeters) |  |
|---------|-------------------|---------|---------|--------|--------------------------|--|
| Pad No. | Signal            | Х       | Υ       | Х      | Υ                        |  |
| 1       | A15               | 71.110  | 52.729  | 1.806  | 1.339                    |  |
| 2       | A14               | 66.008  | 52.729  | 1.677  | 1.339                    |  |
| 3       | A13               | 60.905  | 52.729  | 1.547  | 1.339                    |  |
| 4       | A12               | 55.803  | 52.729  | 1.417  | 1.339                    |  |
| 5       | A11               | 50.700  | 52.729  | 1.288  | 1.339                    |  |
| 6       | A10               | 45.598  | 52.729  | 1.158  | 1.339                    |  |
| 7       | A9                | 40.496  | 52.729  | 1.029  | 1.339                    |  |
| 8       | A8                | 35.393  | 52.729  | 0.899  | 1.339                    |  |
| 9       | WE#               | 25.189  | 52.729  | 0.640  | 1.339                    |  |
| 10      | RESET#            | 20.086  | 52.729  | 0.510  | 1.339                    |  |
| 11      | RY/BY#            | -19.245 | 52.729  | -0.489 | 1.339                    |  |
| 12      | A18               | -29.450 | 52.729  | -0.748 | 1.339                    |  |
| 13      | A17               | -34.553 | 52.729  | -0.878 | 1.339                    |  |
| 14      | A7                | -39.655 | 52.729  | -1.007 | 1.339                    |  |
| 15      | A6                | -44.757 | 52.729  | -1.137 | 1.339                    |  |
| 16      | A5                | -49.860 | 52.729  | -1.266 | 1.339                    |  |
| 17      | A4                | -54.962 | 52.729  | -1.396 | 1.339                    |  |
| 18      | A3                | -60.064 | 52.729  | -1.526 | 1.339                    |  |
| 19      | A2                | -65.167 | 52.729  | -1.655 | 1.339                    |  |
| 20      | A1                | -70.269 | 52.729  | -1.785 | 1.339                    |  |
| 21      | A0                | -70.467 | -52.707 | -1.790 | -1.339                   |  |
| 22      | CE#               | -65.365 | -52.707 | -1.660 | -1.339                   |  |
| 23      | VSS               | -60.261 | -52.707 | -1.531 | -1.339                   |  |
| 24      | OE#               | -51.071 | -52.707 | -1.297 | -1.339                   |  |
| 25      | DQ0               | -44.610 | -52.502 | -1.133 | -1.334                   |  |
| 26      | DQ8               | -39.196 | -52.502 | -0.996 | -1.334                   |  |
| 27      | DQ1               | -33.792 | -52.502 | -0.858 | -1.334                   |  |
| 28      | DQ9               | -28.378 | -52.502 | -0.721 | -1.334                   |  |
| 29      | DQ2               | -22.965 | -52.502 | -0.583 | -1.334                   |  |
| 30      | DQ10              | -17.551 | -52.502 | -0.446 | -1.334                   |  |
| 31      | DQ3               | -12.146 | -52.502 | -0.309 | -1.334                   |  |
| 32      | DQ11              | -6.732  | -52.502 | -0.171 | -1.334                   |  |
| 33      | VCC               | 0.649   | -52.502 | 0.017  | -1.334                   |  |
| 34      | DQ4               | 11.644  | -52.502 | 0.296  | -1.334                   |  |
| 35      | DQ12              | 17.058  | -52.502 | 0.433  | -1.334                   |  |
| 36      | DQ5               | 22.462  | -52.502 | 0.571  | -1.334                   |  |
| 37      | DQ13              | 27.876  | -52.502 | 0.708  | -1.334                   |  |
| 38      | DQ6               | 33.289  | -52.502 | 0.846  | -1.334                   |  |
| 39      | DQ14              | 38.703  | -52.502 | 0.983  | -1.334                   |  |
| 40      | DQ7               | 44.108  | -52.502 | 1.120  | -1.334                   |  |
| 41      | DQ15/A-1          | 49.522  | -52.502 | 1.258  | -1.334                   |  |
| 42      | VSS               | 59.721  | -52.707 | 1.517  | -1.339                   |  |
| 43      | BYTE#             | 64.913  | -52.707 | 1.649  | -1.339                   |  |
| 44      | A16               | 70.016  | -52.707 | 1.778  | -1.339                   |  |

#### Note

The coordinates above are relative to the die center and can be used to operate wire bonding equipment.



**Table 4.2** Pads Relative to  $V_{\rm cc}$ 

| B. 111  | 01              | Pad Center (mils) |         | Pad Center (millimeters) |        |
|---------|-----------------|-------------------|---------|--------------------------|--------|
| Pad No. | Signal          | х                 | Y       | х                        | Υ      |
| 1       | A15             | 70.460            | 105.231 | 1.790                    | 2.673  |
| 2       | A14             | 65.358            | 105.231 | 1.660                    | 2.673  |
| 3       | A13             | 60.256            | 105.231 | 1.531                    | 2.673  |
| 4       | A12             | 55.153            | 105.231 | 1.401                    | 2.673  |
| 5       | A11             | 50.051            | 105.231 | 1.271                    | 2.673  |
| 6       | A10             | 44.949            | 105.231 | 1.142                    | 2.673  |
| 7       | A9              | 39.846            | 105.231 | 1.012                    | 2.673  |
| 8       | A8              | 34.744            | 105.231 | 0.883                    | 2.673  |
| 9       | WE#             | 24.539            | 105.231 | 0.623                    | 2.673  |
| 10      | RESET#          | 19.437            | 105.231 | 0.494                    | 2.673  |
| 11      | RY/BY#          | -19.895           | 105.231 | -0.505                   | 2.673  |
| 12      | A18             | -30.100           | 105.231 | -0.765                   | 2.673  |
| 13      | A17             | -35.202           | 105.231 | -0.894                   | 2.673  |
| 14      | A7              | -40.304           | 105.231 | -1.024                   | 2.673  |
| 15      | A6              | -45.407           | 105.231 | -1.153                   | 2.673  |
| 16      | A5              | -50.509           | 105.231 | -1.283                   | 2.673  |
| 17      | A4              | -55.612           | 105.231 | -1.413                   | 2.673  |
| 18      | А3              | -60.714           | 105.231 | -1.542                   | 2.673  |
| 19      | A2              | -65.816           | 105.231 | -1.672                   | 2.673  |
| 20      | A1              | -70.919           | 105.231 | -1.801                   | 2.673  |
| 21      | A0              | -71.117           | -0.206  | -1.806                   | -0.005 |
| 22      | CE#             | -66.014           | -0.206  | -1.677                   | -0.005 |
| 23      | V <sub>SS</sub> | -60.910           | -0.206  | -1.547                   | -0.005 |
| 24      | OE#             | -51.721           | -0.206  | -1.314                   | -0.005 |
| 25      | DQ0             | -45.260           | 0.000   | -1.150                   | 0.000  |
| 26      | DQ8             | -39.846           | 0.000   | -1.012                   | 0.000  |
| 27      | DQ1             | -34.441           | 0.000   | -0.875                   | 0.000  |
| 28      | DQ9             | -29.027           | 0.000   | -0.737                   | 0.000  |
| 29      | DQ2             | -23.614           | 0.000   | -0.600                   | 0.000  |
| 30      | DQ10            | -18.200           | 0.000   | -0.462                   | 0.000  |
| 31      | DQ3             | -12.796           | 0.000   | -0.325                   | 0.000  |
| 32      | DQ11            | -7.381            | 0.000   | -0.187                   | 0.000  |
| 33      | V <sub>CC</sub> | 0.000             | 0.000   | 0.000                    | 0.000  |
| 34      | DQ4             | 10.994            | 0.000   | 0.279                    | 0.000  |
| 35      | DQ12            | 16.408            | 0.000   | 0.417                    | 0.000  |
| 36      | DQ5             | 21.813            | 0.000   | 0.554                    | 0.000  |
| 37      | DQ13            | 27.227            | 0.000   | 0.692                    | 0.000  |
| 38      | DQ6             | 32.640            | 0.000   | 0.829                    | 0.000  |
| 39      | DQ14            | 38.054            | 0.000   | 0.967                    | 0.000  |
| 40      | DQ7             | 43.458            | 0.000   | 1.104                    | 0.000  |
| 41      | DQ15/A-1        | 48.872            | 0.000   | 1.241                    | 0.000  |
| 42      | V <sub>SS</sub> | 59.072            | -0.206  | 1.500                    | -0.005 |
| 43      | BYTE#           | 64.264            | -0.206  | 1.632                    | -0.005 |
| 44      | A16             | 69.367            | -0.206  | 1.762                    | -0.005 |

Note

The coordinates above are relative to the center of pad 1 and can be used to operate wire bonding equipment.

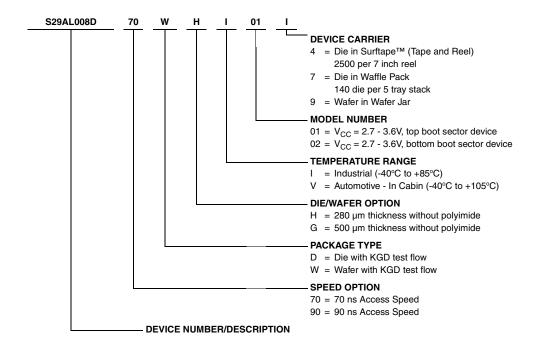


## 5. Ordering Information

This product has been retired and is not recommended for designs. Please contact your Spansion representative for alternates. Availability of this document is retained for reference and historical purposes only.

### 5.1 Standard Products

Spansion standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the elements below.



### **Valid Combinations**

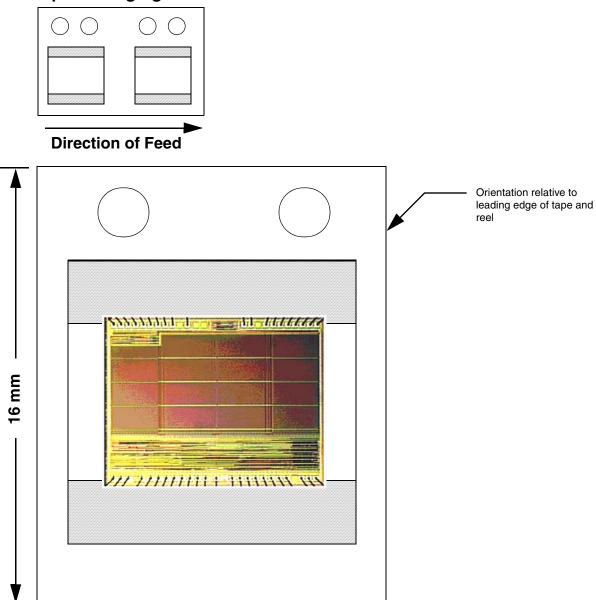
Valid Combinations list configurations planned to be supported in volume for this device. Consult the local Spansion sales office to confirm availability of specific valid combinations and to check on newly released combinations.

| S29AL008D Valid Combinations                                   |        |                    |              |      |
|--|--------|--------------------|--------------|------|
| Device Number Speed Option Package Type, and Temperature Range |        | Model Number       | Die Revision |      |
| S29AL008D 70, 90   | 70.00  | DHI, DGI, DHV, DGV | 01. 02       | 4, 7 |
|  | 70, 90 | WHI, WGI, WHV, WGV | 01,02        | 9    |

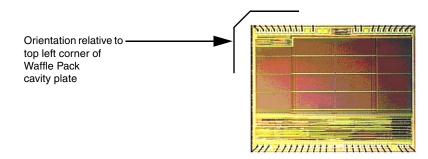


## 6. Packaging Information

## 6.1 Surftape Packaging



## 6.2 Waffle Pack Packaging





#### 7. **Product Test Flow**

Figure 7.1 provides an overview of Spansion's Known Good Die test flow. For more detailed information, refer to the S29AL008D product qualification database supplement for KGD. Spansion implements quality assurance procedures throughout the product test flow. In addition, an off-line quality monitoring program (QMP) further guarantees Spansion quality standards are met on Known Good Die products. These QA procedures also allow Spansion to produce KGD products without requiring or implementing burn-in.

**DC** Parameters Wafer Sort 1 Functionality Programmability

Erasability **Data Retention** Bake 24 hours at 250°C **DC** Parameters Functionality Wafer Sort 2 Programmability Erasability **DC** Parameters Wafer Sort 3 Functionality High Temperature Programmability Erasability Speed Incoming Inspection Wafer Saw Packaging for Shipment Die Separation 100% Visual Inspection Die Pack Shipment

Figure 7.1 Spansion KGD Product Test Flow



### 8. Physical Specifications

| Die dimensions               |                          |
|------------------------------|--------------------------|
| Die Thickness                | 500 μm                   |
| Bond Pad Size                |                          |
| Pad Area Free of Passivation | 10.18 mils²<br>6,561 µm² |
| Pads Per Die                 | 44                       |
| Bond Pad Metalization        | Al/Cu                    |
| Die Backside                 | No metal                 |
| Passivation                  | Nitride/SOG/Nitride      |

## 9. DC Operating Conditions

| V <sub>CC</sub> (Supply Voltage) | 2.7 V to 3.6 V |
|----------------------------------|----------------|
| Operating Temperature            |                |
| Commercial                       |                |
| Industrial                       | -40°C to +85°C |
| Automotive in Cabin              | 40°C to +105°C |

## 10. Manufacturing Information

| Manufacturing               | . Spansion         |
|-----------------------------|--------------------|
| Test                        | . Penang, Malaysia |
| Manufacturing ID (Top Boot) | . 98H19AK          |
| (Bottom Boot)               | . 98H19ABK         |
| Preparation for Shipment    | . Penang, Malaysia |
| Fabrication Process         | . CS49SS           |
| Die Revision                | . 1                |

## 11. Special Handling Instructions

### 11.1 Processing

Do not expose KGD products to ultraviolet light or process them at temperatures greater than 250×C. Failure to adhere to these handling instructions will result in irreparable damage to the devices. For best yield, Spansion recommends assembly in a Class 10K clean room with 30% to 60% relative humidity.

## 11.2 Storage

Store at a maximum temperature of 30°C in a nitrogen-purged cabinet or vacuum-sealed bag. Observe all standard ESD handling procedures.



### 12. Terms and Conditions of Sale for Spansion Non-Volatile Memory Die

All transactions relating to unpackaged die under this agreement shall be subject to Spansion's standard terms and conditions of sale, or any revisions thereof, which revisions Spansion reserves the right to make at any time and from time to time. In the event of conflict between the provisions of Spansion's standard terms and conditions of sale and this agreement, the terms of this agreement shall be controlling.

Spansion warrants its manufactured unpackaged die whether shipped to customer in individual dice or wafer form ("Known Good Die," "KGD", "Die," "Known Good Wafer", "KGW", or Wafer(s)) will meet Spansion's published specifications and against defective materials or workmanship for a period of one (1) year from date of shipment.

This limited warranty does not extend beyond the first purchaser of said Die or Wafer(s).

Buyer assumes full responsibility to ensure compliance with the appropriate handling, assembly and processing of KGD or KGW (including but not limited to proper Die preparation, Die attach, backgrinding, singulation, wire bonding and related assembly and test activities), and compliance with all guidelines set forth in Spansion's specifications for KGD or KGW, and Spansion assumes no responsibility for environmental effects on KGD or KGW or for any activity of Buyer or a third party that damages the Die or Wafer(s) due to improper use, abuse, negligence, improper installation, improper backgrinding, improper singulation, accident, loss, damage in transit, or unauthorized repair or alteration by a person or entity other than Spansion ("Limited Warranty Exclusions")

The liability of Spansion under this limited warranty is limited, at Spansion's option, solely to repair the Die or Wafer(s), to send replacement Die or Wafer(s), or to make an appropriate credit adjustment or refund in an amount not to exceed the original purchase price actually paid for the Die or Wafer(s) returned to Spansion, provided that: (a) Spansion is promptly notified by Buyer in writing during the applicable warranty period of any defect or nonconformity in the Die or Wafer(s); (b) Buyer obtains authorization from Spansion to return the defective Die or Wafer(s); (c) the defective Die or Wafer(s) is returned to Spansion by Buyer in accordance with Spansion's shipping instructions set forth below; and (d) Buyer shows to Spansion's satisfaction that such alleged defect or nonconformity actually exists and was not caused by any of the above-referenced Warranty Exclusions. Buyer shall ship such defective Die or Wafer(s) to Spansion via Spansion's carrier, collect. Risk of loss will transfer to Spansion when the defective Die or Wafer(s) is provided to Spansion's carrier. If Buyer fails to adhere to these warranty returns guidelines, Buyer shall assume all risk of loss and shall pay for all freight to Spansion's specified location. The aforementioned provisions do not extend the original limited warranty period of any Die or Wafer(s) that has either been replaced by Spansion.

THIS LIMITED WARRANTY IS EXPRESSED IN LIEU OF ALL OTHER WARRANTIES, EXPRESSED OR IMPLIED, INCLUDING THE IMPLIED WARRANTY OF FITNESS FOR A PARTICULAR PURPOSE, THE IMPLIED WARRANTY OF MERCHANTABILITY OR NONINFRINGEMENT AND OF ALL OTHER OBLIGATIONS OR LIABILITIES ON Spansion's PART, AND IT NEITHER ASSUMES NOR AUTHORIZES ANY OTHER PERSON TO ASSUME FOR Spansion ANY OTHER LIABILITIES. THE FOREGOING CONSTITUTES THE BUYER'S SOLE AND EXCLUSIVE REMEDY FOR THE FURNISHING OF DEFECTIVE OR NON CONFORMING KNOWN GOOD DIE OR KNOWN GOOD WAFER(S) AND Spansion SHALL NOT IN ANY EVENT BE LIABLE FOR INCREASED MANUFACTURING COSTS, DOWNTIME COSTS, DAMAGES RELATING TO BUYER'S PROCUREMENT OF SUBSTITUTE DIE OR WAFER(S) (i.e., "COST OF COVER"), LOSS OF PROFITS, REVENUES OR GOODWILL, LOSS OF USE OF ORDAMAGE TO ANY ASSOCIATED EQUIPMENT, OR ANY OTHER INDIRECT, INCIDENTAL, SPECIAL OR CONSEQUENTIAL DAMAGES BY REASON OF THE FACT THAT SUCH KNOWN GOOD DIE OR KNOWN GOOD WAFER(S) SHALL HAVE BEEN DETERMINED TO BE DEFECTIVE OR NON CONFORMING.

Buyer agrees that it will make no warranty representations to its customers which exceed those given by Spansion to Buyer unless and until Buyer shall agree to indemnify Spansion in writing for any claims which exceed Spansion's limited warranty. Known Good Die or Known Good Wafer(s) are not designed or authorized for use as components in life support appliances, devices or systems where malfunction of the Die or Wafer(s) can reasonably be expected to result in a personal injury. Buyer's use of Known Good Die or Known Good Wafer(s) for use in life support applications is at Buyer's own risk and Buyer agrees to fully indemnify Spansion for any damages resulting in such use or sale.

Known Good Die or Known Good Wafer are not designed or authorized for use as components in life support appliances, devices or systems where malfunction of the die or wafer can reasonably be expected to result in a personal injury. Buyer's use of Known Good Die or Known Good Wafer for use in life support applications is at Buyer's own risk and Buyer agrees to fully indemnify Spansion for any damages resulting in such use or sale.



# 13. Revision History

| Section                         | Description  |  |  |  |  |
|---------------------------------|--|--|--|--|--|
| Revision A (November 23, 2004)  | Revision A (November 23, 2004)   |  |  |  |  |
|                                 | Initial release.   |  |  |  |  |
| Revision A1 (April 29, 2005)    |  |  |  |  |  |
| Die Photograph & Pad Locations  | Added pad numbers to drawing   |  |  |  |  |
| Pad Description                 | Pads Relative to VCC: Corrected pad number column  |  |  |  |  |
| Revision A2 (May 19, 2005)      |  |  |  |  |  |
| Ordering Information            | Added two types of device carriers, reel and tape; and tray stack  |  |  |  |  |
| Ordering information            | Added package type   |  |  |  |  |
| Valid Combination Table         | Added new package type nomenclature  |  |  |  |  |
| Revision A3 (June 22, 2005)     |  |  |  |  |  |
|                                 | Added Commercial and Industrial values to Temperature Range.   |  |  |  |  |
| Ordering Information            | Added additiional Package Type/Temperature Range values to Valid Combinations tables.                          |  |  |  |  |
| DC Operating Conditions         | Repaired temperature settings  |  |  |  |  |
| Revision A4 (February 9, 2007)  |  |  |  |  |  |
| Manufacturing Information       | Changed test location to Penang, Malaysia  |  |  |  |  |
| Revision A5 (July 17, 2007)     |  |  |  |  |  |
| Ordering Information            | Modified Temperature Range options   |  |  |  |  |
| Valid Combinations Table        | Modified Options   |  |  |  |  |
| Packaging Information           | Removed references to Gel-Pak  |  |  |  |  |
| Revision A6 (February 27, 2009) |  |  |  |  |  |
| Global                          | Added obsolescence information to Distinctive Characteristics and Ordering Information sections of data sheet. |  |  |  |  |



### Colophon

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